Search Notes

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Application/Control No.	Applicant(s)/Patent under Reexamination	
_10/541,166	KIM, HAE-IL	
Examiner	Art Unit	
David J. Walczak	3751	

SEARCHED					
Class	Subclass	Date	Examiner		
401	6, 7, 48, 88	6/21/2006	DW		
16	430				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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